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MOSFET - Power, Single N-Channel

80 V, 6.7 mΩ, 80 A

NVMFS6H836N

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS6H836NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halide Free, and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	80	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Current R _{θ.IC}	Steady State	$T_C = 25^{\circ}C$	۱ _D	74	А
(Notes 1, 3)	State	T _C = 100°C		53	
Power Dissipation		T _C = 25°C	PD	89	W
R _{θJC} (Note 1)		$T_{C} = 100^{\circ}C$		44	
Continuous Drain	Steady State	T _A = 25°C	۱ _D	15	А
Current R _{θJA} (Notes 1, 2, 3)	Siale	T _A = 100°C		11	
Power Dissipation		T _A = 25°C	PD	3.7	W
R _{θJA} (Notes 1, 2)		$T_A = 100^{\circ}C$		1.8	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	432	А
Operating Junction and Storage Temperature Range			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			I _S	74	А
Single Pulse Drain-to-Source Avalanche Energy ($I_{L(pk)} = 4.6 \text{ A}$)			E _{AS}	521	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

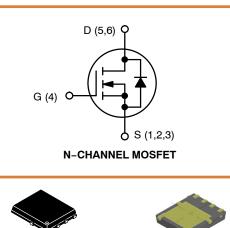
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	1.7	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	40.6	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

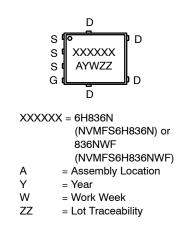
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
80 V	$6.7~\mathrm{m}\Omega @~10~\mathrm{V}$	80 A



DFN5 (SO-8FL) CASE 488AA STYLE 1

DFNW5 5x6 (FULL-CUT SO8FL WF) CASE 507BA

MARKING DIAGRAM



ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

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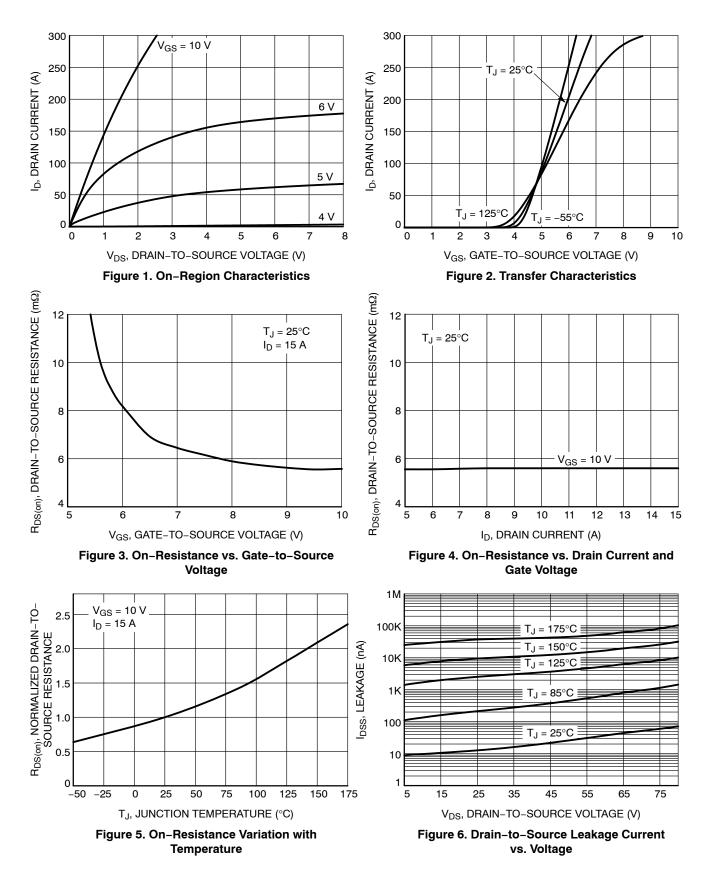
ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_{D} = 250 μ A		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				39		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$ V_{GS} = 0 V, V_{DS} = 80 V $ $ T_{J} = 25^{\circ}C $ $ T_{J} = 125^{\circ}C $				10	μΑ
						100	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 95 \ \mu A$		2.0		4.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-7.3		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 15 A		5.6	6.7	mΩ
Forward Transconductance	9 _{FS}	V _{DS} =15 V, I _D = 25 A			97		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 40 V			1640		pF
Output Capacitance	C _{OSS}				230		-
Reverse Transfer Capacitance	C _{RSS}			8.0			
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 40 V; I_{D} = 25 A			25		nC
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = 10 V, V_{DS} = 40 V; I_{D} = 25 A			5.2		1
Gate-to-Source Charge	Q _{GS}				8.5		1
Gate-to-Drain Charge	Q _{GD}				4.3		1
Plateau Voltage	V _{GP}				4.9		V
SWITCHING CHARACTERISTICS (Note 5	ō)				-	-	
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 64 V, I_{D} = 25 A, R_{G} = 2.5 Ω			16		ns
Rise Time	tr				45		-
Turn–Off Delay Time	t _{d(OFF)}				41		
Fall Time	t _f				34		
DRAIN-SOURCE DIODE CHARACTERIS	STICS	-			-		-
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 15 A	T _J = 25°C		0.8	1.2	V
			T _J = 125°C		0.7		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 25 A			43		ns
Charge Time	ta				29		1
Discharge Time	t _b				15		1
Reverse Recovery Charge	Q _{RR}				54		nC

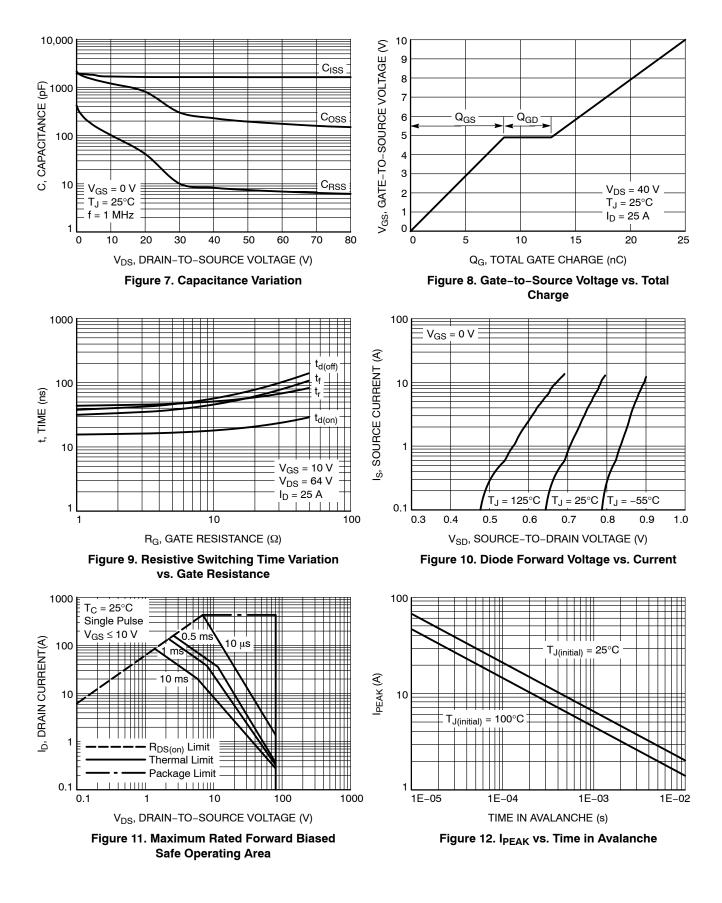
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS (continued)



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TYPICAL CHARACTERISTICS (continued)

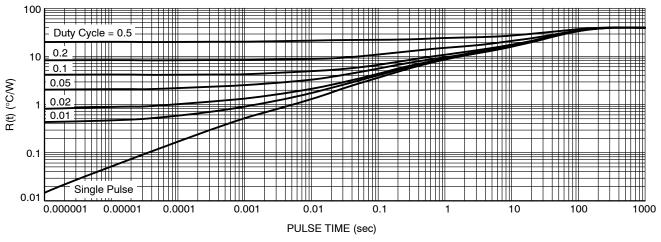
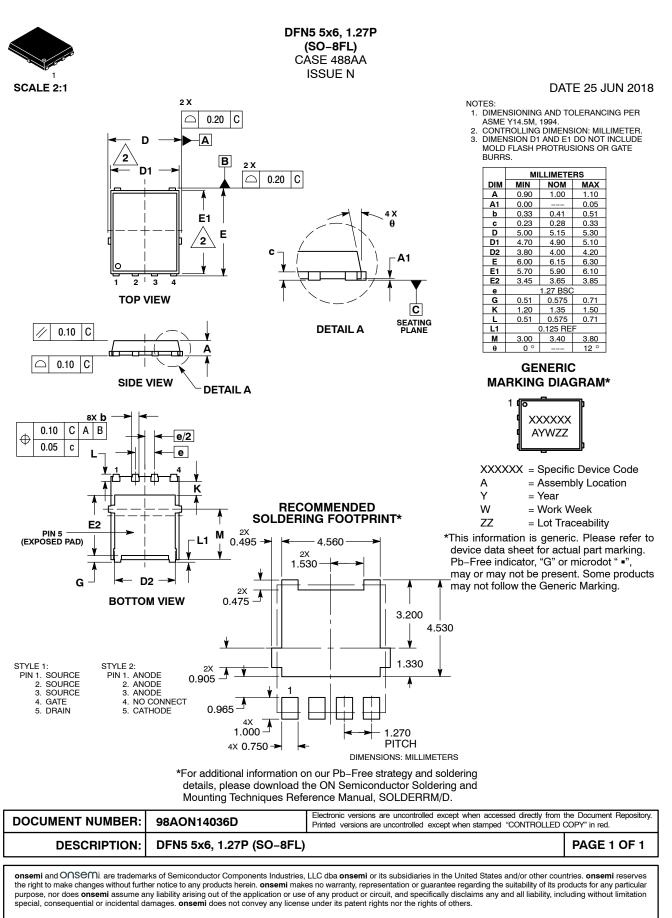


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION						
Device	Marking	Package	Shipping [†]			
NVMFS6H836NT1G	6H836N	DFN5 (Pb-Free, Halide Free)	1500 / Tape & Reel			
NVMFS6H836NT3G	6H836N	DFN5 (Pb-Free, Halide Free)	5000 / Tape & Reel			
NVMFS6H836NWFT1G	836NWF	DFNW5 (Pb-Free, Halide Free, Wettable Flanks)	1500 / Tape & Reel			
NVMFS6H836NWFT3G	836NWF	DFNW5 (Pb-Free, Halide Free, Wettable Flanks)	5000 / Tape & Reel			

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

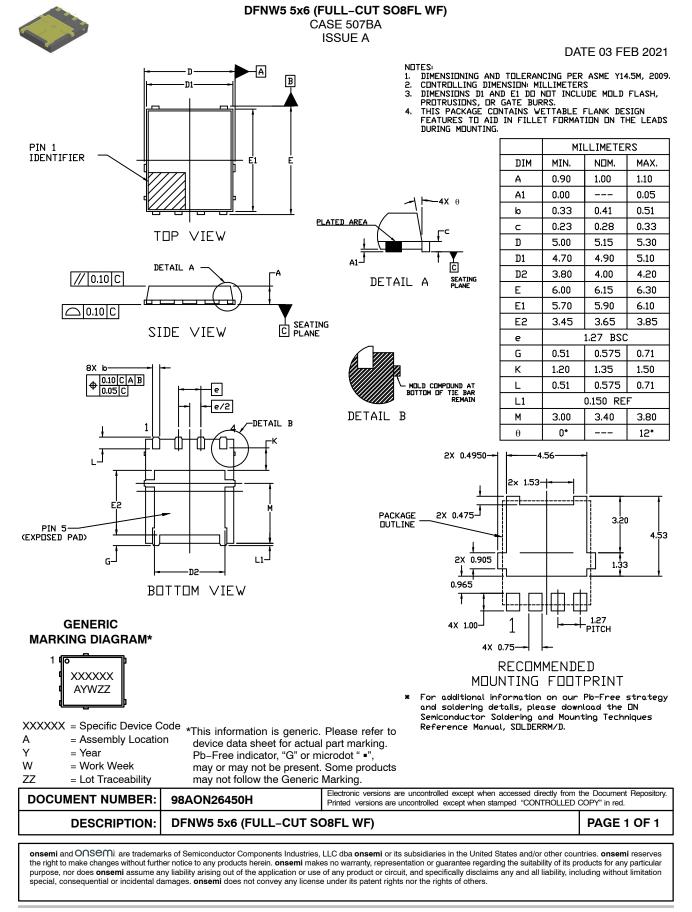
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MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

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